



Zasady Fizyki Mikroskopii Elektronowej: Wprowadzenie do TEM, SEM i AEM

Indeks: **684334** Producent: **Springer** Kod producenta: **9783319819860**

Cena: 201.05 zł

Opis

Physical Principles of Electron Microscopy: An Introduction to TEM, SEM, and AEM

Producent: Springer

- **temat:** Biophysics, Nanotechnology, Spectrum analysis, spectrochemistry, mass spectrometry, Testing of materials, SCIENCE / Life Sciences / Biophysics, SCIENCE / Life Sciences / General, SCIENCE / Nanoscience, Science / Chemistry / Physical & Theoretical, Science / Spectroscopy & Spectrum Analysis, TECHNOLOGY & ENGINEERING / Materials Science / General, TECHNOLOGY & ENGINEERING / Nanotechnology & MEMS, Technology & Engineering / Materials Science, ANF: History, Analytical Electron Microscopy, Ancient, Ancient history, Ancient history: to c 500 CE, Bioanalysis and Bioimaging, Biochemie, Biophysik, Biological Microscopy, Biologie, Biophysics, Biophysik, Characterization and Analytical Technique, Chemie, Chemistry, Chemistry - Physical & Theoretical, Electron Microscope, Electron Microscopy Textbook, Electron Microscopy Textbook; X-ray emission spectroscopy; electron microscope; Analytical Electron Microscopy; optical microscope; scanning electron microscope; scanning transmission electron microscope; Transmission electron microscopy; Biological Microscopy, Electron Microscopy Textbook; X-ray Emission Spectroscopy; Electron Microscope; Analytical Electron Microscopy; Optical Microscope; Scanning Electron Microscope; Scanning Transmission Electron Microscope; Transmission Electron Microscopy; Biological Microscopy, General, HC, HC/Biologie/Biochemie, Biophysik, HC/Chemie/Physikalische Chemie, HC/Technik/Maschinenbau, Fertigungstechnik, HISTORY, HISTORY / Ancient / General, Hardcover, Softcover, Hardcover, Softcover / Technik/Maschinenbau, Fertigungstechnik, Life Sciences, Life Sciences - Biophysics, Maschinenbau, Maschinenbau, Fertigungstechnik, Materials Science, Materials Science - General, Nanoscience, Nanotechnologie, Nanotechnology, Nanotechnology & MEMS, Non-Fiction, Optical Microscope, Physical & Theoretical, Physikalische Chemie, SCI/TECH, SCIENCE, SCIENCE / Chemistry / Physical & Theoretical, SCIENCE / Life Sciences / Biophysics, SCIENCE / Life Sciences / General, SCIENCE / Nanoscience, SCIENCE / Spectroscopy & Spectrum Analysis, Scanning Electron Microscope, Scanning Transmission Electron Microscope, Science/Chemistry - Physical & Theoretical, Science/Life Sciences - Biophysics, Science/Math, Science/Nanoscience, Science/Spectroscopy & Spectrum Analysis, Spectroscopy, Spectroscopy & Spectrum Analysis, Spectrum analysis, spectrochemistry, mass spectrometry, Spektroskopie, Spektrochemie, Massenspektrometrie, Switzerland, TECHNOLOGY & ENGINEERING, TECHNOLOGY & ENGINEERING / Materials Science / General, TECHNOLOGY & ENGINEERING / Nanotechnology & MEMS, Technik, Technology & Engineering/Materials Science - General, Technology & Engineering/Nanotechnology & MEMS, Testing of materials, Transmission Electron Microscopy, Verstehen, Werkstoffprüfung, X-ray Emission Spectroscopy, Biophysik, Nanotechnologie, Spektroskopie, Spektrochemie, Massenspektrometrie, Werkstoffprüfung, HC/Biologie/Biochemie, Biophysik, HC/Chemie/Physikalische Chemie, HC/Technik/Maschinenbau, Fertigungstechnik, Hardcover, Softcover / Technik/Maschinenbau, Fertigungstechnik
- **wiązący:** paperback
- **język:** english, english, english
- **waga przedmiotu:** 1050 grams
- **strony:** 208

- **słowo kluczowe tematu:** Analytical Electron Microscopy, Electron Microscope, Electron Microscopy Textbook, Electron Microscopy Textbook; Transmission Electron Microscopy; Electron Microscope; Analytical Electron Microscopy; Optical Microscope; Scanning Electron Microscope; Scanning Transmission Electron Microscope; X-ray Emission Spectroscopy; Biological Microscopy, Electron Microscopy Textbook; X-ray emission spectroscopy; electron microscope; Analytical Electron Microscopy; optical microscope; scanning electron microscope; scanning transmission electron microscope; Transmission electron microscopy; Biological Microscopy, Electron Microscopy Textbook; X-ray Emission Spectroscopy; Electron Microscope; Analytical Electron Microscopy; Optical Microscope; Scanning Electron Microscope; Scanning Transmission Electron Microscope; Transmission Electron Microscopy; Biological Microscopy, Non-Fiction, Optical Microscope, SCI/TECH, Scanning Electron Microscope, Scanning Transmission Electron Microscope, Science/Math, Switzerland, X-ray Emission Spectroscopy
- **marka:** Springer
- **kod unspsc:** 55101500
- **kod podmiotu:** SCI009000, SCI086000, SCI050000, SCI013050, SCI078000, TEC021000, TEC027000, TEC021000, 1675, 1655, 1682, 1682, PHVN, TBN, PNFS, TGMT, PHVN, TBN, PNFS, TGMT
- **grupa docelowa:** College/University
- **numer części:** 9783319819860
- **kolor:** White
- **waga opakowania przedmiotu:** 0.32 kilograms
- **wydanie:** Softcover reprint of the original 2nd ed. 2016
- **zewnętrznie przypisany identyfikator produktu:** 3319819860, 9783319819860, 09783319819860
- **producent:** Springer
- **autor:** Egerton, R.F.
- **gatunek muzyczny:** Testing of materials, Spectrum analysis, spectrochemistry, mass spectrometry, Biophysics, Nanotechnology, TECHNOLOGY & ENGINEERING, Materials Science, General, SCIENCE, Chemistry, Physical & Theoretical, SCIENCE, Spectroscopy & Spectrum Analysis, SCIENCE, Life Sciences, Biophysics, TECHNOLOGY & ENGINEERING, Nanotechnology & MEMS, SCIENCE, Nanoscience, HC, Technik, Maschinenbau, Fertigungstechnik, HC, Chemie, Physikalische Chemie, HC, Biologie, Biochemie, Biophysik, Testing of materials, Spectrum analysis, spectrochemistry, mass spectrometry, Biophysics, Nanotechnology
- **Data publikacji:** 2018-05-30T00:00:01Z
- **cena katalogowa uvp:** 64.19
- **numer wydania:** 2
- **nazwa przedmiotu:** Physical Principles of Electron Microscopy: An Introduction to TEM, SEM, and AEM
- **data premiery:** 2018-05-30T00:00:01Z
- **data uruchomienia strony produktu:** 2018-05-31T00:04:44.072Z

Parametry

Wydanie	2
Ilość stron	208
Waga	1.05 kg
Język	angielski